Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,935	SHIOTANI ET AL.	ANI ET AL.
Examiner	Art Unit	t
John Q. Nguyen	3654	

	SEARCHED				
Class	Subclass	Date	Examiner		
242	379.1	3/3/2006	JN		
280	805	3/3/2006	JN		
297	471 472	3/3/2006	JN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
 		
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